## <u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOSV)

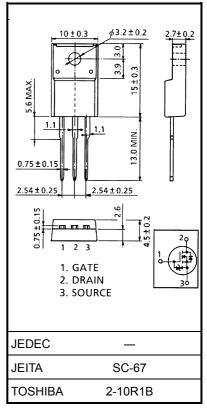
# 2SK2996

## DC–DC Converter, Relay Drive and Motor Drive Applications

- Low drain-source ON resistance  $R_{DS}(ON) = 0.74 \Omega$  (typ.)
- High forward transfer admittance  $|Y_{fs}| = 6.8 \text{ S (typ.)}$
- Low leakage current  $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 600 \ V)$
- Enhancement-mode :  $V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{I}_{D} = 1 \text{ mA})$

#### Maximum Ratings (Ta = 25°C)

| Characteristics                              |                | Symbol           | Rating  | Unit |  |
|--|----------------|------------------|---------|------|--|
| Drain-source voltage                         |                | V <sub>DSS</sub> | 600     | V    |  |
| Drain-gate voltage (R <sub>GS</sub> = 20 kΩ) |                | V <sub>DGR</sub> | 600     | V    |  |
| Gate-source voltage                          |                | V <sub>GSS</sub> | ±30     | V    |  |
| Drain current                                | DC (Note 1)    | ۱ <sub>D</sub>   | 10      | А    |  |
|  | Pulse (Note 1) | I <sub>DP</sub>  | 30      | A    |  |
| Drain power dissipation (Tc = 25°C)          |                | PD               | 45      | W    |  |
| Single pulse avalanche energy<br>(Note 2)    |                | E <sub>AS</sub>  | 252     | mJ   |  |
| Avalanche current                            |                | I <sub>AR</sub>  | 10      | А    |  |
| Repetitive avalanche energy (Note 3)         |                | E <sub>AR</sub>  | 4.5     | mJ   |  |
| Channel temperature                          |                | T <sub>ch</sub>  | 150     | °C   |  |
| Storage temperature range                    |                | T <sub>stg</sub> | -55~150 | °C   |  |



Weight: 1.9 g (typ.)

#### **Thermal Characteristics**

| Characteristics                        | Symbol                 | Max  | Unit   |
|--|------------------------|------|--------|
| Thermal resistance, channel to case    | R <sub>th (ch−c)</sub> | 2.78 | °C/W   |
| Thermal resistance, channel to ambient | R <sub>th (ch−a)</sub> | 62.5 | °C / W |

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V<sub>DD</sub> = 90 V, T<sub>ch</sub> = 25°C (initial), L = 4.41 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 10 A

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm

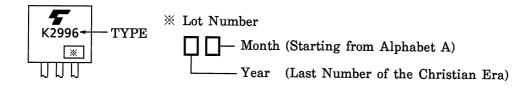
Electrical Characteristics (Ta = 25°C)

| Charac  | teristics                        | Symbol               | Test Condition  | Min | Тур. | Max | Unit |
|---|----------------------------------|----------------------|---|-----|------|-----|------|
| Gate leakage cu                                 | irrent                           | I <sub>GSS</sub>     | V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V  |     |      | ±10 | μA   |
| Gate-source bre                                 | eakdown voltage                  | V (BR) GSS           | I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V  | ±30 |      |     | V    |
| Drain cut-off cu                                | rrent                            | I <sub>DSS</sub>     | V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V  | _   | _    | 100 | μA   |
| Drain-source br                                 | eakdown voltage                  | V (BR) DSS           | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V   | 600 | _    | _   | V    |
| Gate threshold v                                | voltage                          | V <sub>th</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 2.0 | _    | 4.0 | V    |
| Drain-source O                                  | N resistance                     | R <sub>DS (ON)</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A  | _   | 0.74 | 1.0 | Ω    |
| Forward transfer                                | admittance                       | Y <sub>fs</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5 A  | 3.4 | 6.8  | _   | S    |
| Input capacitance                               | put capacitance C <sub>iss</sub> |                      |   | _   | 1500 | _   | pF   |
| Reverse transfer capacitance                    |                                  | C <sub>rss</sub>     | V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz  | _   | 13   | _   |      |
| Output capacitance                              |                                  | Coss                 |   |     | 140  | _   |      |
| Switching time                                  | Rise time                        | tr                   | $V_{GS} \stackrel{10 \text{ V}}{_{0 \text{ V}}} \prod_{\substack{O \text{ V} \\ O \text{ C} \\ O \text{ V}}} \prod_{\substack{O \text{ C} \\ O \text{ V} \\ O \text$ | _   | 15   | _   |      |
|   | Turn-on time                     | t <sub>on</sub>      |   | _   | 55   | _   | 20   |
|   | Fall time                        | t <sub>f</sub>       |   | _   | 27   | _   | ns   |
|   | Turn-off time                    | t <sub>off</sub>     | Duty $\leq 1\%$ , t <sub>w</sub> = 10 µs  | _   | 145  | _   |      |
| Total gate charge (gate-source plus gate-drain) |                                  | Qg                   |   | _   | 38   | _   |      |
| Gate-source charge                              |                                  | Q <sub>gs</sub>      | V <sub>DD</sub> ≈ 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A  |     | 21   | _   | nC   |
| Gate-drain ("miller") Charge                    |                                  | Q <sub>gd</sub>      |   |     | 17   | —   |      |

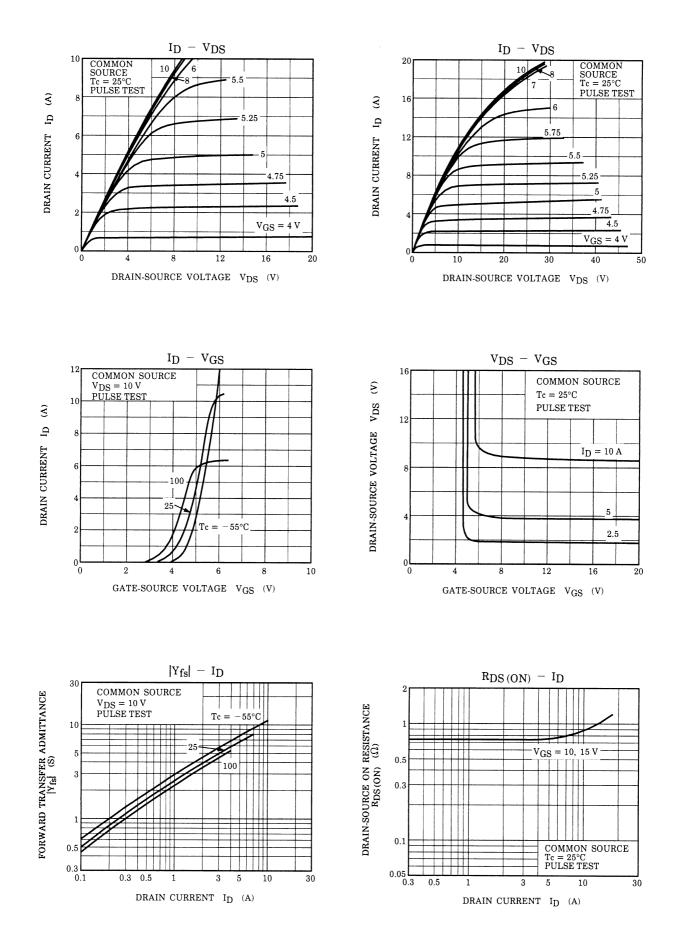
#### Source–Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                              | Symbol           | Test Condition  | Min | Тур. | Max  | Unit |
|--|------------------|---|-----|------|------|------|
| Continuous drain reverse current<br>(Note 1) | I <sub>DR</sub>  | —   |     | _    | 10   | А    |
| Pulse drain reverse current<br>(Note 1)      | I <sub>DRP</sub> | —   | _   | _    | 30   | А    |
| Forward voltage (diode)                      | V <sub>DSF</sub> | I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V                                       | _   | _    | -1.7 | V    |
| Reverse recovery time                        | t <sub>rr</sub>  | I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V<br>dI <sub>DR</sub> / dt = 100 A / μs | _   | 1600 |      | ns   |
| Reverse recovery charge                      | Qrr              | dI <sub>DR</sub> / dt = 100 A / μs  |     | 17   |      | μC   |

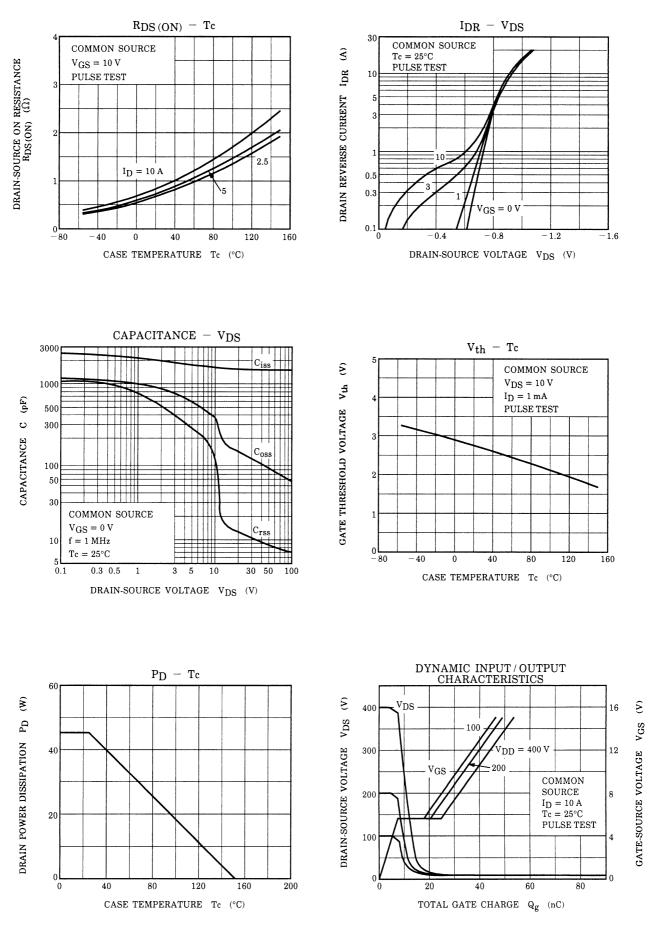
#### Marking

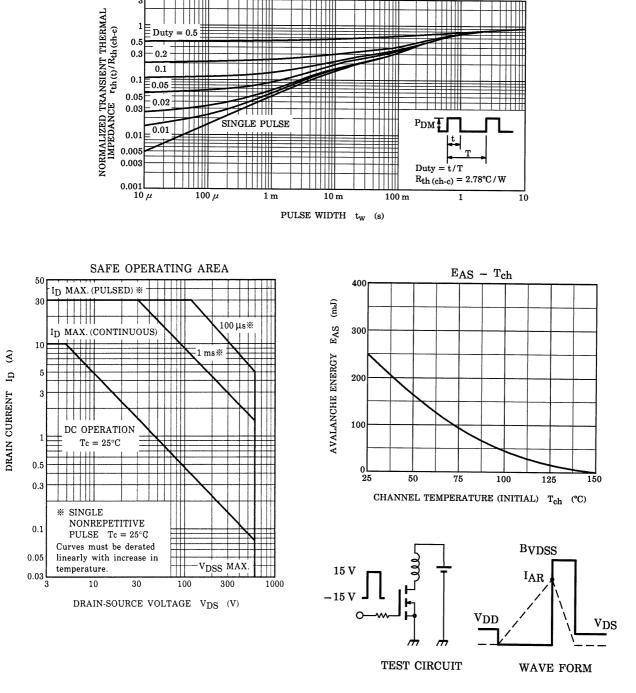


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 $r_{th} - t_w$ 

 $\begin{array}{ll} \mathrm{R_{G}=25\ \Omega} \\ \mathrm{V_{DD}=90\ V,\ L=4.41\ mH} \end{array} \qquad \mathrm{E_{AS}=\frac{1}{2}\cdot L\cdot I^{2}\cdot \left(\frac{\mathrm{B}\mathrm{VDSS}}{\mathrm{B}\mathrm{VDSS}-\mathrm{VDD}}\right)} \end{array}$ 

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